

FB7430-VB Datasheet

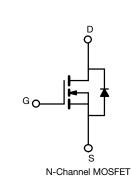
N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	40				
$R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$	0.00084				
I _D (A)	409				
Configuration	Single				
Qg (nC)	250				

TO-220AB

Ο

GDS



FEATURES

- Trench Power MOSFET
- 100 % Rg and UIS Tested ٠

APPLICATIONS

- Synchronous Rectification •
- ٠ **Power Supplies**



COMPLIANT HALOGEN FREE

Top View	Top View N-			
ABSOLUTE MAXIMUM RATING	S (T _C = 25 °C, unless	otherwise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage Gate-source voltage		V _{DS}	40	V
		V _{GS}	± 20	V
Continuous drain current ^a	T _C = 25 °C	- I _D	409	
	T _C = 125 °C		320	
Continuous source current (diode conduction	on) ^a		409	А
Pulsed drain current ^b		I _{DM}	600	
Single pulse avalanche current	L = 0.1 mH	I _{AS}	100	
Single pulse avalanche energy	L = 0.1 MH	E _{AS}	500	mJ
Maximum power dissipation ^b	T _C = 25 °C	P	375	14/
	T _C = 125 °C	PD	125	W
Operating junction and storage temperature	erange	T _J , T _{stg}	-55 to +175	°C

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-ambient	PCB mount ^c	R _{thJA}	40	°C/W		
Junction-to-case (drain)		R _{thJC}	0.4	0/10		

Notes

a. Based on T = 25 °C.

b. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

c. When mounted on 1" square PCB (FR4 material)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static		•						
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		40	-	-	v	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.5	3.0	3.5	v	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$		-	-	± 100	nA	
	I _{DSS}	$V_{GS} = 0 V$ $V_{DS} = 40 V$		-	-	1		
Zero gate voltage drain current		$V_{GS} = 0 V$	V _{DS} = 40 V, T _J = 125 °C	-	-	50	μA	
		$V_{GS} = 0 V$	V _{DS} = 40 V, T _J = 175 °C	-	-	300	μA	
On-state drain current ^a	I _{D(on)}	V _{GS} = 10 V	$V_{DS} \ge 5 V$	100	-	-	Α	
	- ()	V _{GS} = 10 V	I _D = 35 A	-	0.00084	-		
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 10 V	I _D = 35 A, T _J = 125 °C	-	0.00140	-	Ω	
		V _{GS} = 10 V	I _D = 35 A, T _J = 175 °C	-	0.00164	-		
Forward transconductance b	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 30 \text{ A}$		-	196	-	S	
Dynamic ^b		•					•	
Input capacitance	C _{iss}			-	11 938	15 525		
Output capacitance	C _{oss}	$V_{GS} = 0 V$	V _{GS} = 0 V V _{DS} = 25 V, f = 1 MHz		11 163	14 520	pF	
Reverse transfer capacitance	C _{rss}			-	282	370		
Total gate charge ^c	Qg			-	158	250		
Gate-source charge ^c	Q _{gs}	$V_{GS} = 10 \text{ V}$ $V_{DS} = 20 \text{ V}, I_D = 100 \text{ A}$		-	44	-	nC	
Gate-drain charge ^c	Q _{gd}			-	22	-		
Gate resistance	Rg	f = 1 MHz		2.70	5.44	8.20	Ω	
Turn-on delay time ^c	t _{d(on)}	$V_{DD} = 20 \text{ V}, \text{ R}_{\text{L}} = 0.2 \Omega$ $\text{I}_{\text{D}} \cong 100 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		-	16	25		
Rise time ^c	t _r			-	10	17		
Turn-off delay time ^c	t _{d(off)}			-	103	160	- ns	
Fall time ^c	t _f			-	61	95		
Source-Drain Diode Ratings and Chara	cteristics ^b							
Pulsed current ^a	I _{SM}			-	-	260	Α	
Forward voltage	V _{SD}	$I_F = 60 \text{ A}, V_{GS} = 0 \text{ V}$		-	0.81	1.5	V	
Body diode reverse recovery time	t _{rr}	I _F = 30 A, di/dt = 100 A/μs		-	165	350	ns	
Body diode reverse recovery charge	Q _{rr}			-	530	1100	nC	
Reverse recovery fall time	t _a			-	66	-		
Reverse recovery rise time	t _b			-	99	-	ns	
Body diode peak reverse recovery current	I _{RM(REC)}			-	-6.2	-	Α	

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$

b. Guaranteed by design, not subject to production testing

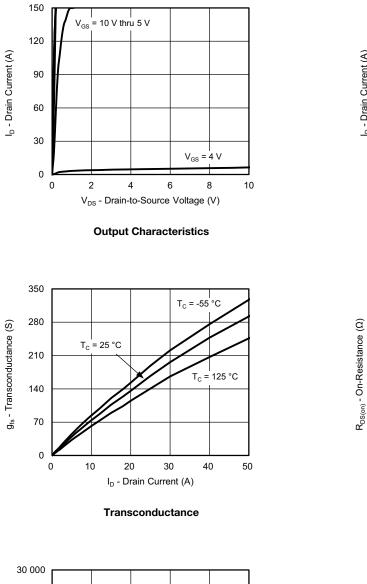
c. Independent of operating temperature

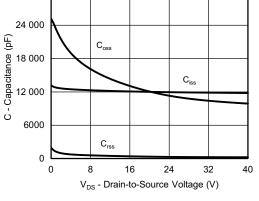
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi

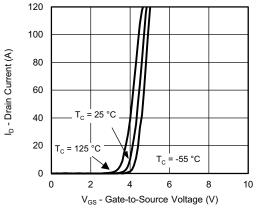


TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)

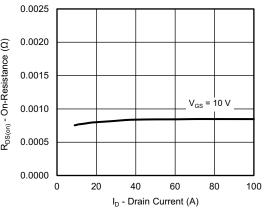




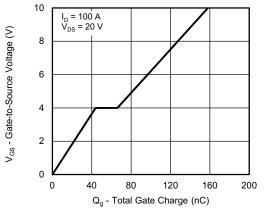
Capacitance



Transfer Characteristics



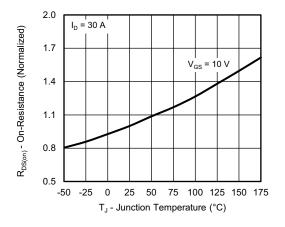
On-Resistance vs. Drain Current



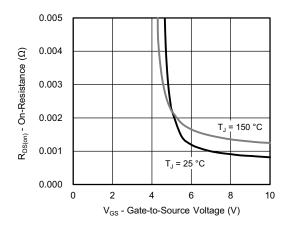
Gate Charge



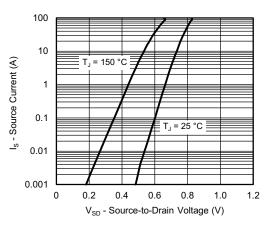
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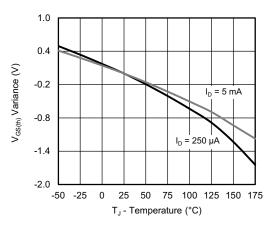
On-Resistance vs. Junction Temperature

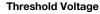


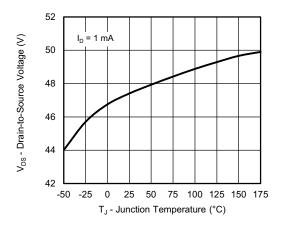
On-Resistance vs. Gate-to-Source Voltage



Source Drain Diode Forward Voltage



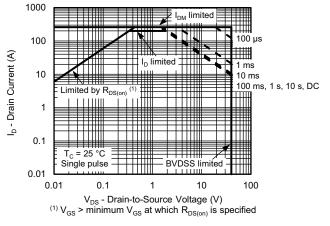




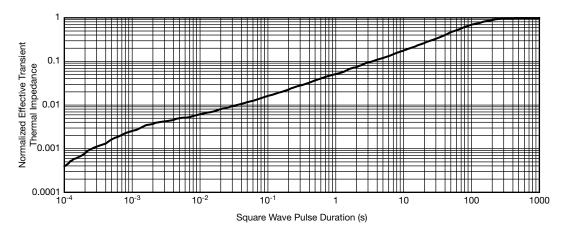
Drain Source Breakdown vs. Junction Temperature



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



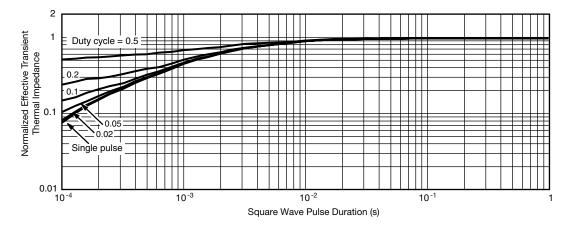
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS ($T_A = 25 \text{ °C}$, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

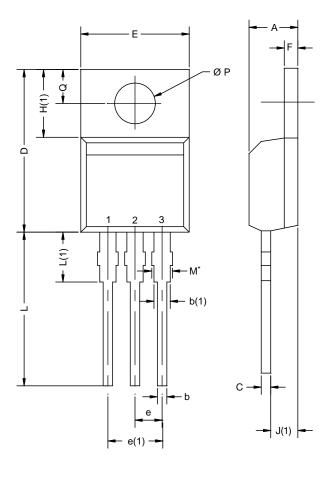
Note

- The characteristics shown in the two graphs
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions



TO-220AB



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
с	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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